

**Search Notes**

Application/Control No.

10/653,826

Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

LAI ET AL.

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Tod Swann (Method & Apparatus claims are 101 issue)	7/30/2007	MAI